CRMPBL0308A

P-Channel -30V, 8.3mΩ Typ. Power MOSFET

Description

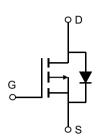
Features

• -30V, -15A

$$R_{DS(ON)}$$
 Typ = 8.3m Ω @ V_{GS} = -10 V

$$R_{DS(ON)}$$
 Typ = $12m\Omega$ @ V_{GS} = -4.5V

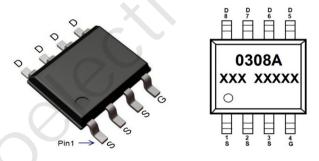
- Advanced Trench Technology
- Excellent R_{DS(ON)} and Low Gate Charge
- Lead Free
- 100% UIS TESTED!





Application

- Load Switch
- PWM Application
- Power Management



Marking and Pin Assignment

Package Marking and Ordering Information

Device	Marking	Package	Outline	Reel Size	Reel (pcs)	Per Carton (pcs)
CRMPBL0308A	0308A	SOP-8	TAPING	13"	4000	40000

Absolute Maximum Ratings (@ T_J = 25°C unless otherwise specified)

Symbol	Parameter		Value	Units
V_{DS}	Drain-to-Source Voltage		-30	V
V _{GS}	Gate-to-Source Voltage		±20	V
I _D	Continuous Drain Current	T _A = 25°C	-15	А
	Continuous Drain Current	T _A = 100°C	-9	А
I _{DM}	Pulsed Drain Current ⁽¹⁾		-60	А
E _{AS}	Single Pulsed Avalanche Energy (2)		64	mJ
P_{D}	Power Dissipation	T _A = 25°C	4.1	W
$R_{ heta JA}$	Thermal Resistance, Junction to Ambier	nt ⁽³⁾	30	°C/W
T_J , T_STG	Junction & Storage Temperature Range		-55 to 150	°C

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Electrical Characteristics (T_J = 25°C unless otherwise specified)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Uni
Off Chara	acteristics					
V _{(BR)DSS}	Drain-Source Breakdown Voltage	$I_D = -250 \mu A, V_{GS} = 0 V$	-30	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -30V, V_{GS} = 0V$	-	-	-1.0	μΑ
I _{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	±100	nA
On Chara	acteristics				6	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-1.1	-1.5	-2.2	V
R _{DS(ON)}	Static Drain-Source ON-Resistance ⁽⁴⁾	$V_{GS} = -10V, I_D = -3A$	-	8.3	10.8	mΩ
		$V_{GS} = -4.5V, I_D = -2A$	-	12	15.6	mΩ
Dynamic	Characteristics					
C _{iss}	Input Capacitance		-(1403	-	pF
C_{oss}	Output Capacitance	$V_{GS} = 0V, V_{DS} = -15V,$ f = 1MHz	X - \	250	-	pF
C_{rss}	Reverse Transfer Capacitance	1 - 1101112	-	217	-	pF
Q_g	Total Gate Charge) -	25	-	nC
Q_gs	Gate Source Charge	$V_{GS} = 0 \text{ to } -10V$ $V_{DS} = -15V, I_D = -10A$	-	4	-	nC
Q_{gd}	Gate Drain("Miller") Charge	V _{DS} = -13V, I _D = -10A	-	5.5	-	nC
Switchin	g Characteristics					
t _{d(on)}	Turn-On DelayTime	.()	-	11	-	ns
t _r	Turn-On Rise Time	$V_{GS} = -10V, V_{DD} = -15V$	-	17	-	ns
$t_{\text{d(off)}}$	Turn-Off DelayTime	I_D = -10A, R_{GEN} = 3Ω	-	60	-	ns
t_f	Turn-Off Fall Time		-	45	-	ns
Drain-So	urce Diode Characteristics and M	Max Ratings				
I _S	Maximum Continuous Drain to Source Diode Forward Current			-	-15	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current		-	-	-60	Α
V _{SD}	Drain to Source Diode Forward Voltage	$V_{GS} = 0V$, $I_S = -3A$	-	-	-1.2	V
trr	Body Diode Reverse Recovery Time	1 - 404 - 4:/	-	15	-	ns
Qrr	Body Diode Reverse Recovery Charge	$I_F = -10A$, di/dt = 100A/us	-	6	-	nC

Notes:

^{1.} Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.

^{2.} E_{AS} condition: Starting T_J =25°C, V_{DD} =-15V, V_G =-10V, R_G =25ohm, L=0.5mH, I_{AS} =-16A

^{3.} $R_{\scriptscriptstyle \theta JA}$ is measured with the device mounted on a 1inch² pad of 2oz copper FR4 PCB

^{4.} Pulse Test: Pulse Width≤300µs, Duty Cycle≤0.5%.

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Test Circuit

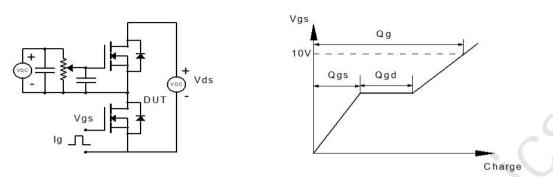


Figure 1: Gate Charge Test Circuit & Waveform

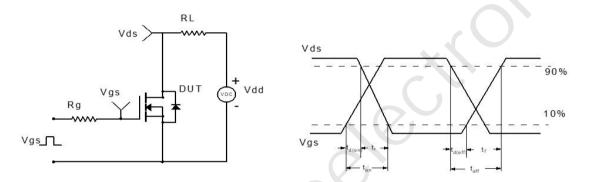


Figure 2: Resistive Switching Test Circuit & Waveform

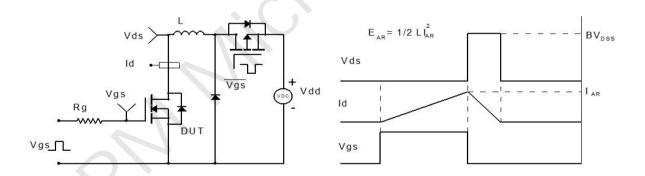


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

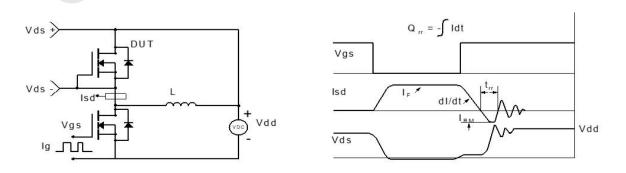
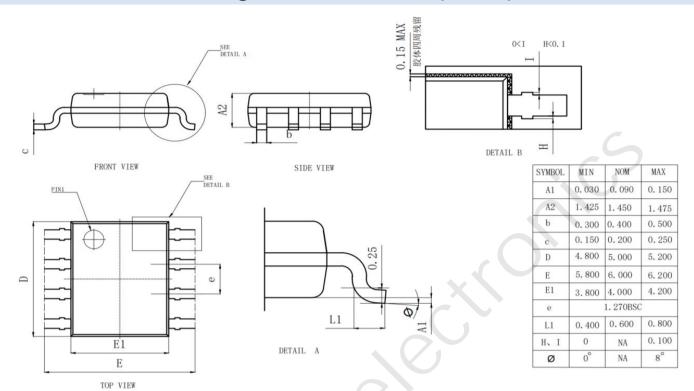


Figure 4: Diode Recovery Test Circuit & Waveform

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Package Mechanical Data(SOP-8)



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